

FODM611 High Noise Immunity, 5V, 10Mbit/sec Logic Gate Output (Open Collector) Optocoupler

Features

FAIRCHILD

SEMICONDUCTOR

- High Noise Immunity characterized by common mode transient immunity (CMTi)
 - 20kV/µs Minimum CMTi
- High Speed
 - 10Mbit/sec Date Rate (NRZ)
 - 100ns max. Propagation Delay
 - 35ns max. Pulse Width Distortion
 - 40ns max. Propagation Delay Skew
- -40 to +85°C temperature range
- Safety and regulatory approvals
 - UL1577, 3750 VAC_{RMS} for 1 min.
 - IEC60747-5-2 (pending approval)

Applications

- Microprocessor system interface
 SPI, I²C
- Industrial fieldbus communications
- DeviceNet, CAN, RS485
- Programmable logic control
- Isolated data acquisition system
- Voltage level translator
- Isolating MOSFET/IGBT gate drivers

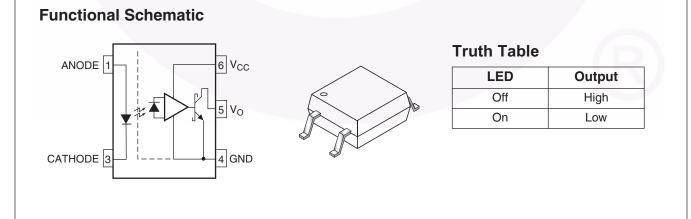
Description

The FODM611 is a 5V high-speed logic gate output (open collector) optocoupler, which supports isolated communications allowing digital signals to communicate between systems without conducting ground loops or hazardous voltages. It utilizes Fairchild's proprietary coplanar packaging technology, Optoplanar[®], and optimized IC design to achieve high noise immunity, characterized by high common mode transient immunity specifications.

This optocoupler consists of an AlGaAS LED at the input, optically coupled to a high speed integrated photodetector logic gate. The output of the detector IC is an open collector schottky-clamped transistor. The coupled parameters are guaranteed over the wide temperature range of -40°C to +85°C. A maximum input signal of 5mA will provide a minimum output sink current of 13mA (fan out of 8).

Related Resources

- www.fairchildsemi.com/products/opto/
- www.fairchildsemi.com/pf/FO/FODM8061.html
- www.fairchildsemi.com/pf/FO/FODM8071.html



Pin Definitions

Number	Name	Function Description
1	ANODE	Anode
3	CATHODE	Cathode
4	GND	Output Ground
5	V _O	Output Voltage
6	V _{CC}	Output Supply Voltage

Safety and Insulation Ratings for Mini-Flat Package (SO5 Pin)

As per IEC60747-5-2 (Pending Certification). This optocoupler is suitable for "safe electrical insulation" only within the safety limit data. Compliance with the safety ratings shall be ensured by means of protective circuits.

Symbol	Parameter	Min.	Тур.	Max.	Unit
	Installation Classifications per DIN VDE 0110/1.89 Table 1				
	For rated main voltage < 150Vrms		I-IV		
	For rated main voltage < 300Vrms		I-III		
	Climatic Classification		40/85/21		
	Pollution Degree (DIN VDE 0110/1.89)		2		
CTI	Comparative Tracking Index	175			
V _{PR}	Input to Output Test Voltage, Method b, VIORM x 1.875 = V_{PR} , 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	1060			
V _{PR}	Input to Output Test Voltage, Method a, VIORM x 1.5 = V_{PR} , Type and Sample Test with $t_m = 60$ sec, Partial Discharge < 5 pC	848			
VIORM	Max Working Insulation Voltage	565			V _{peak}
V _{IOTM}	Highest Allowable Over Voltage	4000			V _{peak}
	External Creepage	5.0			mm
	External Clearance	5.0			mm
	Insulation thickness	0.5			mm
T _{Case}	Safety Limit Values, Maximum Values allowed in the event of a failure, Case Temperature	150			°C
R _{IO}	Insulation Resistance at T _S , V _{IO} = 500V	10 ⁹			Ω

Absolute Maximum Ratings (TA=25°C unless otherwise specified)

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Value	Units
T _{STG}	Storage Temperature	-40 to +125	°C
T _{OPR}	Operating Temperature	-40 to +85	°C
TJ	Junction Temperature	-40 to +125	°C
T _{SOL}	Lead Solder Temperature (Refer to Reflow Temperature Profile)	260 for 10sec	°C
I _F	Forward Current	50	mA
V _R	Reverse Voltage	5.0	V
V _{CC}	Supply Voltage	0 to 7.0	V
Vo	Output Voltage	-0.5 to V _{CC} +0.5	V
Ι _Ο	Average Output Current	50	mA
PDI	Input Power Dissipation ⁽¹⁾⁽²⁾	100	mW
PD _O	Output Power Dissipation ⁽¹⁾⁽²⁾	85	mW

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

Symbol	Parameter	Min.	Max.	Unit
T _A	Ambient Operating Temperature	-40	+85	°C
V _{CC}	Supply Voltages ⁽³⁾	4.5	5.5	V
V _{FL}	Logic Low Input Voltage	0	0.8	V
I _{FH}	Logic High Input Current	6.3	15	mA
I _{FL}	Logic Low Input Current		250	μA
N	Fan Out (at $R_L = 1k\Omega$)		5	TTL Loads
RL	Output Pull-up Resistor	330	4k	Ω

Isolation Characteristics (T_A=25°C)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V _{ISO}	Input-Output Isolation Voltage	freq= 60Hz, t = 1.0min, $I_{I-O} \leq 10 \mu A^{(4)(5)}$	3750			Vac _{RMS}
R _{ISO}	Isolation Resistance	$V_{I-O} = 500V^{(4)}$		10 ¹²		Ω
C _{ISO}	Isolation Capacitance	V _{I-O} = 0V, freq=1.0MHz ⁽⁴⁾		0.6		pF

Notes:

- 1. No derate required to 85°C.
- 2. Functional operation under these conditions is not implied. Permanent damage may occur if the device is subjected to conditions outside these ratings.
- 3. $0.1 \mu F$ bypass capacitor must be connected between pins 4 and 6.
- 4. Device is considered a two terminal device: Pins 1 and 3 are shorted, and Pins 4, 5, and 6 are shorted together.
- 5. 3,750 VAC_{RMS} for 1 minute duration is equivalent to 4,500 VAC_{RMS} for 1 second duration.

Electrical Characteristics (Apply over all recommended conditions)

(T_A = -40°C to +85°C, 4.5V \leq V_{CC} \leq 5.5V), unless otherwise specified. Typical value is measured at T_A = 25°C and V_{CC} = 5.0V.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
INPUT CH	IARACTERISTICS	1				
V _F	Forward Voltage	I _F = 10mA, Fig. 1	1.05	1.45	1.8	V
BV _R	Input Reverse Breakdown Voltage	I _R = 10μA	5.0			V
I _{FHL}	Threshold Input Current	$V_{O} = 0.6V$, $I_{OL}(sinking) = 13mA$, $T_{A} < 85^{\circ}C$, Fig. 2		3.4	5.0	mA
OUTPUT	CHARACTERISTICS		•			
V _{OL}	Logic LOW Output Voltage	I_F = rated I_{FHL} , I_{OL} (sinking) = 13mA, Fig. 3		0.4	0.6	V
I _{OH}	Logic HIGH Output Current	I _F = 250μA, V _O = 5.0V, Fig. 4	1	2.1	30.0	μA
I _{CCL}	Logic LOW Output Supply Current	I _F = 10mA, V _{CC} = 5.0V, Fig. 5, 7		7.5	10.0	mA
I _{CCH}	Logic HIGH Output Supply Current	I _F = 0mA, V _{CC} = 5.0V, Fig. 6, 7		6.0	9.0	mA

Switching Characteristics (Apply over all recommended conditions)

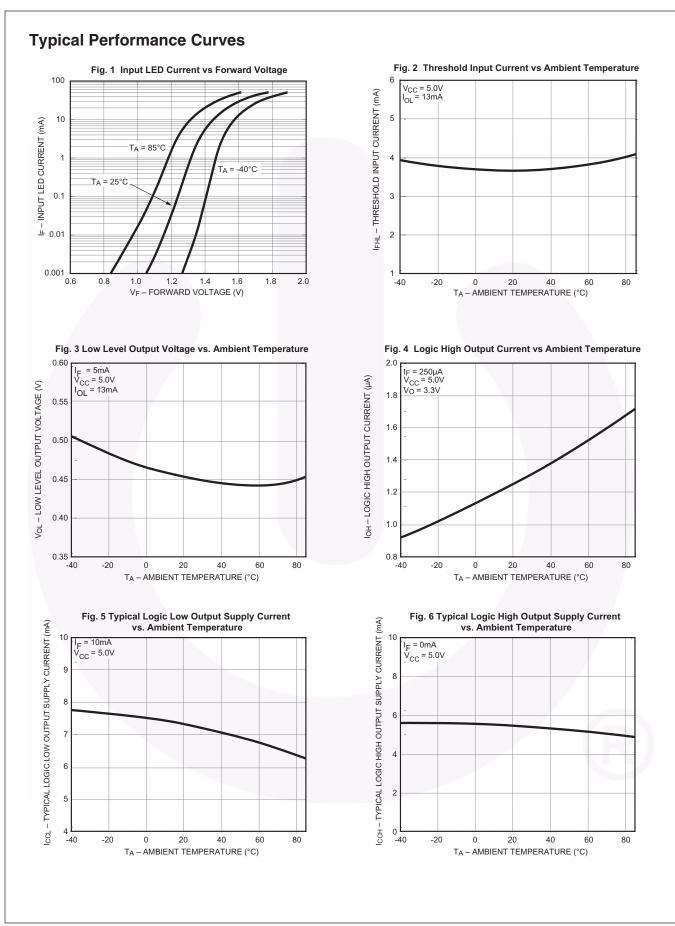
(T_A = -40°C to +85°C, 4.5V \leq V_{CC} \leq 5.5V, I_F = 7.5mA), unless otherwise specified. Typical value is measured at T_A = 25°C and V_{CC} = 5.0V

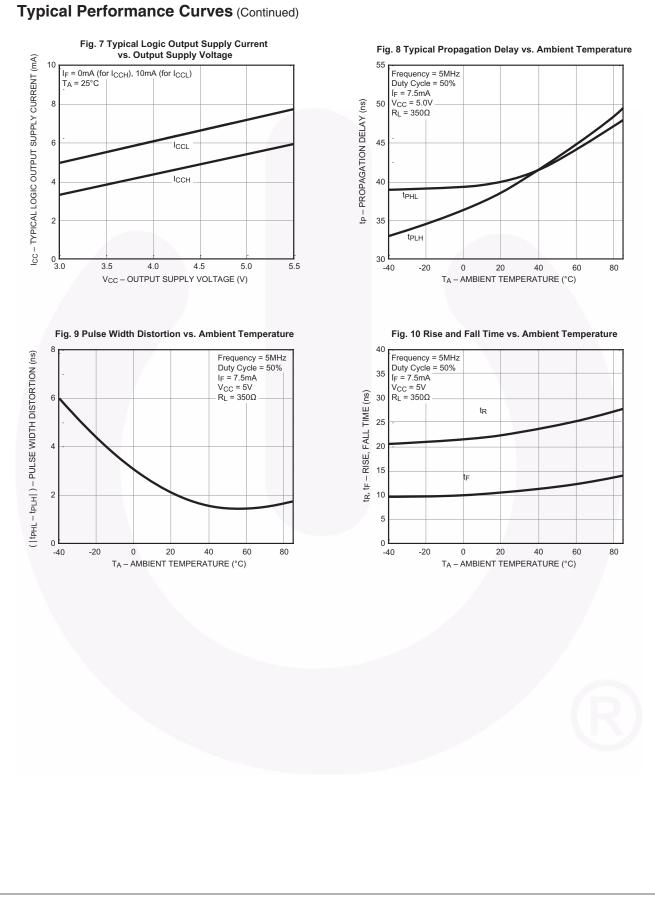
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Date Rate		R _L = 350Ω			10	Mbps
t _{PHL}	Propagation Delay Time to Logic Low Output	$R_L = 350\Omega$, $C_L = 15pF$, Fig. 8 and 11		43	100	ns
t _{PLH}	Propagation Delay Time to Logic High Output	$R_L = 350\Omega$, $C_L = 15pF$, Fig. 8 and 11		50	100	ns
PWD	Pulse Width Distortion, t _{PHL} – t _{PLH}	$R_L = 350\Omega$, $C_L = 15pF$, Fig. 9		7	35	ns
t _{PSK}	Propagation Delay Skew	$R_L = 350\Omega, C_L = 15pF^{(6)}$			40	ns
t _R	Output Rise Time, (10% to 90%)	R _L = 350Ω, C _L = 15pF, Fig. 10 and 11		20		ns
t _F	Output Fall Time, (90% to 10%)	$R_L = 350\Omega$, $C_L = 15pF$, Fig. 10 and 11		10		ns
CM _H	Common Mode Transient Immunity at Output High	$V_{I} = 5.0V, V_{O} > 0.8 \text{ x} V_{CC},$ $V_{CM} = 1000V^{(7)}, Fig. 12$	20	40		kV/µs
CM _L	Common Mode Transient Immunity at Output Low	$V_{I} = 0V, V_{O} < 0.8V,$ $V_{CM} = 1000V^{(7)},$ Fig. 12	20	40		kV/µs

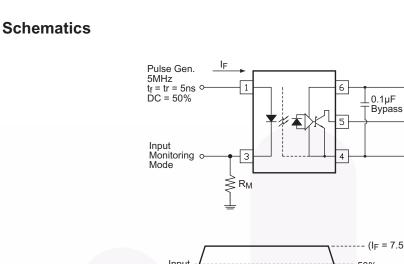
Notes

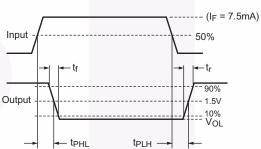
6. t_{PSK} is equal to the magnitude of the worst case difference in t_{PHL} and/or t_{PLH} that will be seen between any two units from the same manufacturing date code that are operated at same case temperature (±5°C), at same operating conditions, with equal loads ($R_L = 350\Omega$ and $C_L = 15pF$), and with an input rise time less than 5ns.

7. Common mode transient immunity at output high is the maximum tolerable positive dVcm/dt on the leading edge of the common mode impulse signal, Vcm, to assure that the output will remain high. Common mode transient immunity at output low is the maximum tolerable negative dVcm/dt on the trailing edge of the common pulse signal, Vcm, to assure that the output will remain low.







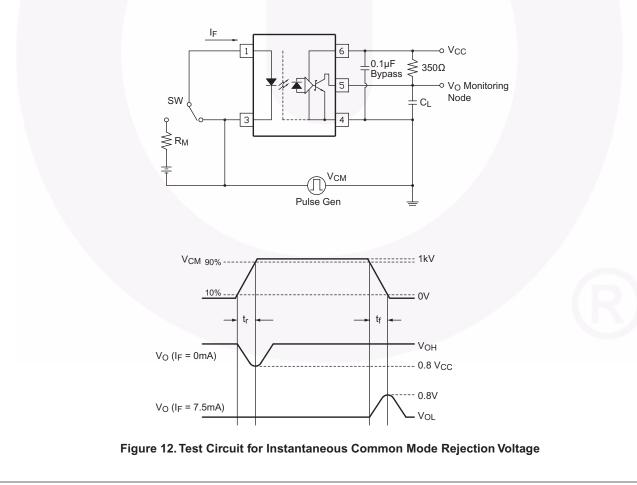


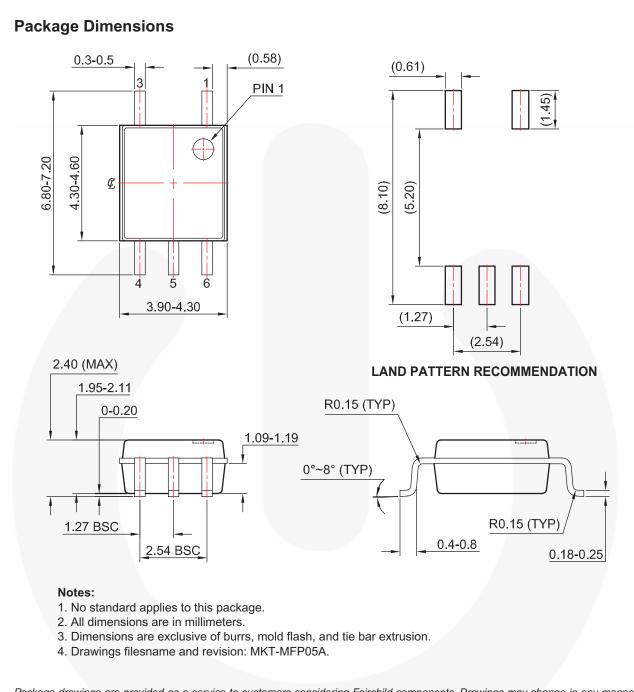


350Ω

CL^{Node}

Vo Monitoring





Package drawings are provided as a service to customers considering Fairchild components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a Fairchild Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of Fairchild's worldwide terms and conditions, specifically the warranty therein, which covers Fairchild products.

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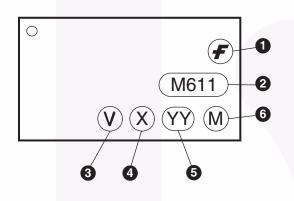
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Ordering Information

Option	Order Entry Identifier (Example)	Description
No Suffix	FODM611	Mini-Flat 5-pin, shipped in tubes (100 units per tube)
R2	FODM611R2	Mini-Flat 5-pin, tape and reel (2,500 units per reel)

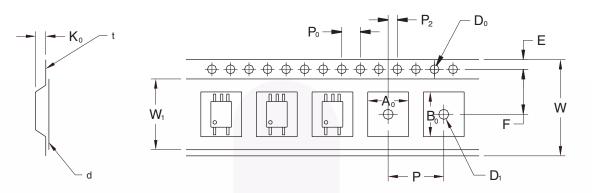
All packages are lead free per JEDEC: J-STD-020B standard.

Marking Information

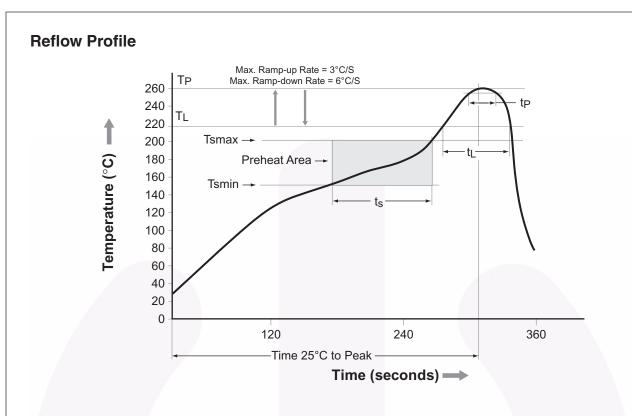


Definiti	ons	
1	Fairchild logo	
2	Device number	
3	EC60747-5-2 (VDE marking)	
4	One digit year code, e.g., '9'	
5	Two digit work week ranging from '01' to '53'	
6	Assembly package code	

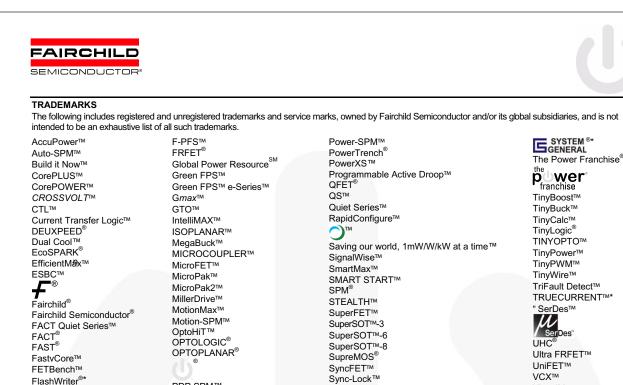
Tape and Reel Dimensions



	Γ	2.54 Pitch
Description	Symbol	Dimensions (mm)
Tape Width	W	12.00 +0.30/-0.10
Tape Thickness	t	0.30 ±0.05
Sprocket Hole Pitch	P ₀	4.00 ±0.10
Sprocket Hole Diameter	D ₀	1.50 +0.10/-0.0
Sprocket Hole Location	E	1.75 ±0.10
Pocket Location	F	5.50 ±0.10
	P ₂	2.00 ±0.10
Pocket Pitch	Р	8.00 ±0.10
Pocket Dimension	A ₀	4.40 ±0.10
	B ₀	7.30 ±0.10
	K ₀	2.30 ±0.10
Pocket Hole Diameter	D ₁	1.50 Min.
Cover Tape Width	W ₁	9.20
Cover Tape Thickness	d	0.065 ±0.010
Max. Component Rotation or Tilt		10° Max.
Devices Per Reel		2500
Reel Diameter		330mm (13")



Profile Feature	Pb-Free Assembly Profile		
Temperature Min. (Tsmin)	150°C		
Temperature Max. (Tsmax)	200°C		
Time (t _S) from (Tsmin to Tsmax)	60–120 seconds		
Ramp-up Rate (t _L to t _P)	3°C/second max.		
Liquidous Temperature (T _L)	217°C		
Time (t _L) Maintained Above (T _L)	60–150 seconds		
Peak Body Package Temperature	260°C +0°C / –5°C		
Time (t _P) within 5°C of 260°C	30 seconds		
Ramp-down Rate (T _P to T _L)	6°C/second max.		
Time 25°C to Peak Temperature	8 minutes max.		



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PDP SPM™

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Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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